

SN74AVC4T245 Dual-Bit Bus Transceiver with Configurable Voltage Translation and 3-State Outputs

1 Features

- Control inputs VIH/VIL levels are referenced to V_{CCA} voltage
- Fully configurable dual-rail design allows each port to operate over the full 1.2V to 3.6V power-supply range
- I/Os Are 4.6V tolerant
- Ioff supports partial power-down-mode operation
- Maximum data rates:
 - 380Mbps (1.8V to 3.3V translation)
 - 200Mbps (< 1.8V to 3.3V translation)
 - 200Mbps (translate to 2.5V or 1.8V)
 - 150Mbps (translate to 1.5V)
 - 100Mbps (translate to 1.2V)
- Latch-up performance exceeds 100mA per JESD 78, Class II
- ESD protection exceeds JESD 22:
 - 8000V Human-Body Model (A114-A)
 - 150V Machine Model (A115-A)
 - 1000V Charged-Device Model (C101)

2 Applications

- Personal electronics •
- Industrial ٠
- Enterprise
- Telecom

3 Description

This 4-bit noninverting bus transceiver uses two separate configurable power-supply rails. The A port is designed to track V_{CCA}. V_{CCA} accepts any supply voltage from 1.2V to 3.6V. The B port is designed to track V_{CCB}. V_{CCB} accepts any supply voltage from 1.2V to 3.6V. The SN74AVC4T245 is optimized

to operate with $V_{\text{CCA}}/V_{\text{CCB}}$ set at 1.4V to 3.6V. It is operational with V_{CCA}/V_{CCB} as low as 1.2V. This allows for universal low-voltage bidirectional translation between any of the 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V voltage nodes.

SN74AVC4T245 The device is designed for asynchronous communication between two data buses. The logic levels of the direction-control (DIR) input and the output-enable (\overline{OE}) input activate either the B-port outputs or the A-port outputs or place both output ports into the high-impedance mode. The device transmits data from the A bus to the B bus when the B-port outputs are activated, and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports is always active and must have a logic HIGH or LOW level applied to prevent excess I_{CC} and I_{CCZ}.

The SN74AVC4T245 device is designed so that V_{CCA} supplies the control pins (1DIR, 2DIR, 1 OE, and 2 OE).

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

The V_{CC} isolation feature is designed so that if either V_{CC} input is at GND, then both ports are in the highimpedance state.

To put the device in the high-impedance state during power up or power down, tie \overline{OE} to V_{CC} through a pullup resistor; the current-sinking capability of the driver determines the minimum value of the resistor.

Package mormation										
PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾								
	D (SOIC, 16)	9.9mm × 6mm								
	DGV (TVSOP, 16)	3.6mm × 6.4mm								
	PW (TSSOP, 16)	5mm × 6.4mm								
SN74AVC4T245	RGY (WQFN, 16)	4mm × 3.5mm								
	RSV (UQFN, 16)	2.6mm × 1.8mm								
	BQB (WQFN, 16)	3.5mm × 2.5mm								
	DYY (SOT, 16)	4.2mm × 2mm								

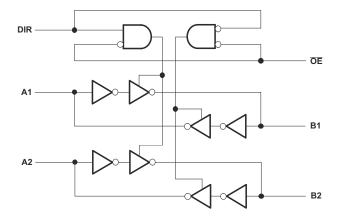
Package Information

For more information, see Section 11. (1)



⁽²⁾ The package size (length × width) is a nominal value and includes pins, where applicable.





Logic Diagram (Positive Logic) for 1/2 of SN74AVC4T245



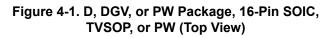
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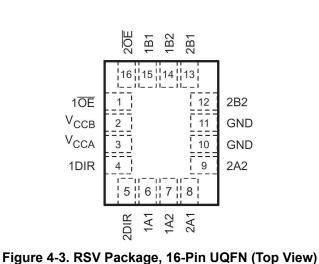
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V _{CCA} 1DIR 2DIR 1A1 1A2 2A1 2A2	1 2 3 4 5 6 7	16 15 14 13 12 11 10	V _{CCB} 10E 20E 1B1 1B2 2B1 2B2
2A2	7	10	
GND	8	9	GND





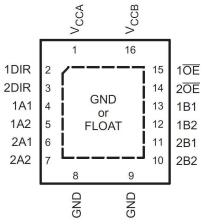


Figure 4-2. RGY Package, 16-Pin WQFN (Top View)

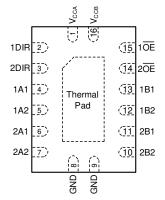


Figure 4-4. BQB/WBQB Package, 16-Pin WQFN (Transparent Top View)

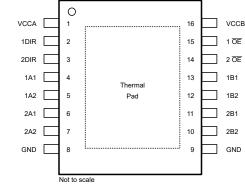


Figure 4-5. DYY Package, 16-Pin SOT (Top View)



Table 4-1. Pin Functions PIN NO. TYPE⁽¹⁾ DESCRIPTION D, DGV, PW, NAME RSV RGY 1A1 Input/output 1A1. Referenced to V_{CCA}. 4 6 I/O 1A2 7 5 I/O Input/output 1A2. Referenced to V_{CCA}. 1B1 13 15 I/O Input/output 1B1. Referenced to V_{CCB}. 1B2 12 14 I/O Input/output 1B2. Referenced to V_{CCB}. 1DIR 2 Direction-control input for '1' ports 4 I 3-state output-mode enables. Pull OE high to place '1' outputs in 3-state 1 <u>OE</u> 15 I 1 mode. Referenced to V_{CCA}. 2A1 6 I/O Input/output 2A1. Referenced to V_{CCA}. 8 Input/output 2A2. Referenced to V_{CCA}. 2A2 7 9 I/O 2B1 Input/output 2B1. Referenced to V_{CCB}. 11 13 I/O 2B2 10 I/O Input/output 2B2. Referenced to V_{CCB}. 12 2DIR 3 5 I Direction-control input for '2' ports 3-state output-mode enables. Pull OE high to place '2' outputs in 3-state 2 <u>OE</u> 14 16 L mode. Referenced to V_{CCA}. GND 8, 9 10, 11 Ground V_{CCA} 1 3 A-port power supply voltage. $1.2V \le V_{CCA} \le 3.6V$ _ 2 B-port power supply voltage. $1.2V \le V_{CCB} \le 3.6V$ V_{CCB} 16 ____

(1) I = input, O = output



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

			MIN ⁽¹⁾	MAX	UNIT	
V _{CCA} V _{CCB}	Supply voltage range		-0.5	4.6	V	
		I/O ports (A port)	-0.5	4.6		
VI	Input voltage range ⁽²⁾	I/O ports (B port)	-0.5	4.6	V	
		Control inputs	-0.5	4.6		
V	Voltage range applied to any output in the high-impedance or	A port	-0.5	4.6	V	
Vo	power-off state ⁽²⁾	B port	-0.5	4.6	v	
V.	Voltage range applied to any output in the high or low state ^{(2) (3)}	A port	-0.5	V _{CCA} + 0.5	V	
Vo	Voltage range applied to any output in the high of low state (7.67	B port	-0.5	V _{CCB} + 0.5	v	
I _{IK}	Input clamp current	V ₁ < 0		-50	mA	
I _{OK}	Output clamp current	V _O < 0		-50	mA	
lo	Continuous output current		±50	mA		
	Continuous current through V_{CCA} , V_{CCB} , or GND		±100	mA		
T _{stg}	Storage temperature range		-65	150	°C	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

(2) The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The output positive-voltage rating may be exceeded up to 4.6V maximum if the output current rating is observed.

5.2 ESD Ratings

			MIN	MAX	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾		8	kV
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾		1	κv
		Machine model (C101)		150	V

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.



5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)^{(1) (2) (3)}

			V _{CCI}	V _{cco}	MIN	MAX	UNIT
V _{CCA}	Supply voltage				1.2	3.6	V
V _{CCB}	Supply voltage				1.2	3.6	V
			1.2V to 1.95V		V _{CCI} × 0.65		
V _{IH}	High-level input voltage	Data inputs ⁽⁴⁾	1.95V to 2.7V		1.6		V
	mpar voltago		2.7V to 3.6V		2		
			1.2V to 1.95V			V _{CCI} × 0.35	
VIL	Low-level input voltage	Data inputs ⁽⁴⁾	1.95V to 2.7V			0.7	V
	mpar voltago		2.7V to 3.6V			0.8	
			1.2V to 1.95V		V _{CCA} × 0.65		
V _{IH}	High-level input voltage	DIR (referenced to V _{CCA}) ⁽⁵⁾	1.95V to 2.7V		1.6		V
	mpar voltago		2.7V to 3.6V		2		
			1.2V to 1.95V			$V_{CCA} \times 0.35$	
VIL	Low-level input voltage	DIR (referenced to V _{CCA}) ⁽⁵⁾	1.95V to 2.7V			0.7	V
	input tonage		2.7V to 3.6V			0.8	
VI	Input voltage				0	3.6	V
V	Output valtage	Active state			0	V _{cco}	V
Vo	Output voltage	3-state			0	3.6	v
				1.2V		-3	
				1.4V to 1.6V		-6	
I _{OH}	High-level output cur	rent		1.65V to 1.95V		-8	mA
				2.3V to 2.7V		-9	
				3V to 3.6V		–12	
				1.1V to 1.2V		3	
				1.4V to 1.6V		6	
I _{OL}	Low-level output curr	rent		1.65V to 1.95V		8	mA
				2.3V to 2.7V		9	
				3V to 3.6V		12	
Δt/Δv	Input transition rise o	r fall rate				5	ns/V
T _A	Operating free-air ter	mperature			-40	85	°C

(1) V_{CCI} is the V_{CC} associated with the input port.

(2) V_{CCO} is the V_{CC} associated with the output port.

(3) All unused data inputs of the device must be held at V_{CCI} or GND for proper device operation. Refer to the *Implications of Slow or* Floating CMOS Inputs application report.

(4) For V_{CCI} values not specified in the data sheet, V_{IH} min = V_{CCI} × 0.7V, V_{IL} max = V_{CCI} × 0.3V (5) For V_{CCI} values not specified in the data sheet, V_{IH} min = V_{CCA} × 0.7V, V_{IL} max = V_{CCA} × 0.3V



5.4 Thermal Information

				SI	N74AVC4T	245			
	THERMAL METRIC ⁽¹⁾	D	BQB	DYY	DGV	PW	RGY	RSV	UNIT
		16 PINS							
R _{0JA}	Junction-to-ambient thermal resistance	85.5	80.8	163.4	126.0	102.8	68.8	146.9	
R _{0JC(top)}	Junction-to-case (top) thermal resistance	46.9	77.9	90.0	50.8	35.9	70.6	53.6	
R _{θJB}	Junction-to-board thermal resistance	43.0	50.7	93.1	57.7	57.5	45.0	75.6	
Ψ _{JT}	Junction-to-top characterization parameter	13.4	7.4	10.9	5.7	1.6	11.9	13.5	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	42.7	50.6	92.1	57.2	56.9	44.7	75.6	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	_	28.4	_	_	_	28.2	_	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report.



5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER ⁽¹⁾		TEST CONDI	TIONS	v	v	T,	_A = 25°C		–40°C to 8	5°C	UNIT
	(2)	TEST CONDI	TIONS	V _{CCA}	V _{CCB}	MIN	TYP	MAX	MIN	MAX	UNIT
		I _{OH} = –100μA		1.2V to 3.6V	1.2V to 3.6V				$V_{CCO} - 0.2$		
		I _{OH} = -3mA	1	1.2V	1.2V		0.95				
		I _{OH} = –6mA	V _I = V _{IH}	1.4V	1.4V				1.05		V
V _{OH}		I _{OH} = -8mA	v _I – v _{IH}	1.65V	1.65V				1.2		v
		I _{OH} = –9mA		2.3V	2.3V				1.75		
		I _{OH} = -12mA		3V	3V				2.3		
		I _{OL} = 100μA		1.2V to 3.6V	1.2V to 3.6V					0.2	
		I _{OL} = 3mA]	1.2V	1.2V		0.25				
V _{OL}		I _{OL} = 6mA	V _I = V _{IL}	1.4V	1.4V					0.35	V
		I _{OL} = 8mA		1.65V	1.65V					0.45	v
	I _{OL} = 9mA	2.3V		2.3V					0.55		
		I _{OL} = 12mA	1	3V	3V					0.7	
l _l	Control inputs	V _I = V _{CCA} or GND		1.2V to 3.6V	1.2V to 3.6V		±0.025	±0.25		±1	μA
	A an D mant			0V	0V to 3.6V		±0.1	±1		±5	
I _{off}	A or B port	$V_{\rm I} \text{ or } V_{\rm O} = 0 \text{ to } 3.6$	V	0V to 3.6V	0V		±0.1	±1		±5	μA
I _{OZ}	A or B port	$V_0 = V_{CC0}$ or GNE $V_1 = V_{CC1}$ or GND,), OE = V _{IH}	3.6V	3.6V		±0.5	±2.5		±5	μA
				1.2V to 3.6V	1.2V to 3.6V					8	
I _{CCA}		$V_{I} = V_{CCI}$ or GND,	I _O = 0	0V	0V to 3.6V					-2	μA
				0V to 3.6V	0V					8	
				1.2V to 3.6V	1.2V to 3.6V					8	
I _{CCB}		$V_{I} = V_{CCI}$ or GND,	I _O = 0	0V	0V to 3.6V					8	μA
					0V					-2	
I _{CCA} +	· I _{CCB}	$V_{I} = V_{CCI}$ or GND,	I _O = 0	1.2V to 3.6V	1.2V to 3.6V					16	μA
Ci	Control inputs	V _I = 3.3V or GND		3.3V	3.3V		3.5			4.5	pF
Cio	A or B port	V _O = 3.3V or GND		3.3V	3.3V		6			7	pF

 $\begin{array}{ll} (1) & V_{CCI} \text{ is the } V_{CC} \text{ associated with the input port.} \\ (2) & V_{CCO} \text{ is the } V_{CC} \text{ associated with the output port.} \end{array}$



5.6 Operating Characteristics

T_A = 25°C

Р	ARAME	TER	TEST CONDITIONS	V _{CCA} = V _{CCB} = 1.2V	V _{CCA} = V _{CCB} = 1.5V	V _{CCA} = V _{CCB} = 1.8V	V _{CCA} = V _{CCB} = 2.5V	V _{CCA} = V _{CCB} = 3.3V	UNIT	
			CONDITIONS	ТҮР	ТҮР	ТҮР	ТҮР	ТҮР		
	A to B	Outputs enabled		1	1	1	1.5	2		
C _{pdA} ⁽¹⁾ B to A	Outputs disabled	C _L = 0, f = 10MHz,	1	1	1	1	1	pF		
	Outputs enabled	$t_r = t_f = 1$ ns	12	12.5	13	14	15			
	DIOA	Outputs disabled		1	1	1	1	1		
	A to B	Outputs enabled		12	12.5	13	14	15		
C = (1)	7.00	Outputs disabled	C _L = 0, f = 10MHz,	1	1	1	1	1	pF	
OpdB (C _{pdB} ⁽¹⁾ B to A	Outputs enabled	$t_r = t_f = 1$ ns	1	1	1	1	2	рч 	
		Outputs disabled		1	1	1	1	1		

(1) Power dissipation capacitance per transceiver

5.7 Switching Characteristics: V_{CCA} = 1.2V

over recommended operating free-air temperature range, V_{CCA} = 1.2V (unless otherwise noted) (see Figure 6-1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.2V	V _{CCB} = 1.5V ± 0.1V	V _{CCB} = 1.8V ± 0.15V	V _{CCB} = 2.5V ± 0.2V	V _{CCB} = 3.3V ± 0.3V	UNIT	
		(001701)	ТҮР	TYP	TYP	TYP	TYP		
t _{PLH}	А	В	3.4	2.9	2.7	2.6	2.8	ns	
t _{PHL}	~	В	3.4	2.9	2.7	2.6	2.8	115	
t _{PLH}	В	А	3.6	3.1	2.8	2.6	2.6	n 0	
t _{PHL}	D	A	3.6	3.1	2.8	2.6	2.6	ns	
t _{PZH}	ŌĒ	٨	5.6	4.7	4.3	3.9	3.7	ns	
t _{PZL}	UE	A	5.6	4.7	4.3	3.9	3.7	113	
t _{PZH}	ŌĒ	В	5	4.3	3.9	3.6	3.6	ns	
t _{PZL}	OL	В	5	4.3	3.9	3.6	3.6	115	
t _{PHZ}	ŌĒ	٨	6.2	5.2	5.2	4.3	4.8		
t _{PLZ}	0E	A	6.2	5.2	5.2	4.3	4.8	ns	
t _{PHZ}		DE B		5.1	5	4.7	5.5	ns	
t _{PLZ}	0E	6	5.9	5.1	5	4.7	5.5	115	



5.8 Switching Characteristics: V_{CCA} = $1.5V \pm 0.1V$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.2V	V _{CCB} = ± 0.		V _{CCB} = 1.8V ± 0.15V		V _{CCB} = 2.5V ± 0.2V		V _{CCB} = 3.3V ± 0.3V		UNIT	
			ТҮР	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
t _{PLH}	А	В	3.2	0.3	6.3	0.3	5.2	0.4	4.2	0.4	4.2	ns	
t _{PHL}			3.2	0.3	6.3	0.3	5.2	0.4	4.2	0.4	4.2	115	
t _{PLH}	В	A	3.3	0.7	6.3	0.5	6	0.4	5.7	0.3	5.6	ns	
t _{PHL}	D	D	~	3.3	0.7	6.3	0.5	6	0.4	5.7	0.3	5.6	115
t _{PZH}	ŌĒ	А	4.9	1.4	9.6	1.1	9.5	0.7	9.4	0.4	9.4	ns	
t _{PZL}	UL		4.9	1.4	9.6	1.1	9.5	0.7	9.4	0.4	9.4	115	
t _{PZH}	ŌĒ	В	4.5	1.4	9.6	1.1	7.7	0.9	5.8	0.9	5.6	ns	
t _{PZL}	UL		4.5	1.4	9.6	1.1	7.7	0.9	5.8	0.9	5.6	115	
t _{PHZ}	ŌĒ	А	5.6	1.8	10.2	1.5	10.2	1.3	10.2	1.6	10.2	ns	
t _{PLZ}	UE		5.6	1.8	10.2	1.5	10.2	1.3	10.2	1.6	10.2	115	
t _{PHZ}	ŌĒ	В	5.2	1.9	10.3	1.9	9.1	1.4	7.4	1.2	7.6	ns	
t _{PLZ}	UL		5.2	1.9	10.3	1.9	9.1	1.4	7.4	1.2	7.6	115	

over recommended operating free-air temperature range, $V_{CCA} = 1.5V \pm 0.1V$ (see Figure 6-1)

5.9 Switching Characteristics: $V_{CCA} = 1.8V \pm 0.15V$

over recommended operating free-air temperature range, V_{CCA} = 1.8V ± 0.15V (see Figure 6-1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.2V	V _{ССВ} = ± 0.1		V _{ССВ} = ± 0.1		V _{CCB} = ± 0.1		V _{CCB} = ± 0.3		UNIT								
		(001201)	ТҮР	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX									
t _{PLH}	А	В	2.9	0.1	6	0.1	4.9	0.1	3.9	0.3	3.9	ns								
t _{PHL}	A	D	2.9	0.1	6	0.1	4.9	0.1	3.9	0.3	3.9	115								
t _{PLH}	В	А	3	0.6	5.3	0.5	4.9	0.3	4.6	0.3	4.5	ns								
t _{PHL}	D	~	3	0.6	5.3	0.5	4.9	0.3	4.6	0.3	4.5	115								
t _{PZH}	ŌĒ	А	4.4	1	7.4	1	7.3	0.6	7.3	0.4	7.2	ns								
t _{PZL}	UL	~	4.4	1	7.4	1	7.3	0.6	7.3	0.4	7.2	115								
t _{PZH}	ŌĒ	В	4.1	1.2	9.2	1	7.4	0.8	5.3	0.8	4.6	ns								
t _{PZL}	UL	В	4.1	1.2	9.2	1	7.4	0.8	5.3	0.8	4.6	115								
t _{PHZ}	ŌĒ	А	5.4	1.6	8.6	1.8	8.7	1.3	8.7	1.6	8.7	ns								
t _{PLZ}	UE	~	5.4	1.6	8.6	1.8	8.7	1.3	8.7	1.6	8.7	115								
t _{PHZ}		В	5	1.7	9.9	1.6	8.7	1.2	6.9	1	6.9	nc								
t _{PLZ}	ŌĒ	ŌĒ	ŌĒ	ŌĒ	ŌĒ	ŌĒ	ŌĒ	ŌĒ	ŌĒ	0	5	1.7	9.9	1.6	8.7	1.2	6.9	1	6.9	ns

5.10 Switching Characteristics: $V_{CCA} = 2.5V \pm 0.2V$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.2V	V _{CCB} = ± 0.7		V _{CCB} = ± 0.1		V _{CCB} = 2.5V ± 0.2V		V _{CCB} = 3.3V ± 0.3V		UNIT																													
		(001201)	ТҮР	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX																														
t _{PLH}	А	В	2.8	0.1	5.7	0.1	4.6	0.2	3.5	0.1	3.6	ns																													
t _{PHL}	A	D	2.8	0.1	5.7	0.1	4.6	0.2	3.5	0.1	3.6	115																													
t _{PLH}	В	А	2.7	0.6	4.2	0.4	3.9	0.2	3.4	0.2	3.3	ns																													
t _{PHL}	D	~	2.7	0.6	4.2	0.4	3.9	0.2	3.4	0.2	3.3	115																													
t _{PZH}	ŌĒ	А	4	0.7	6.5	0.7	5.2	0.6	4.8	0.4	4.8	ns																													
t _{PZL}	UE	A	4	0.7	6.5	0.7	5.2	0.6	4.8	0.4	4.8	115																													
t _{PZH}	ŌĒ	В	3.8	0.9	8.8	0.8	7	0.6	4.8	0.6	4	ns																													
t _{PZL}	UL	В	3.8	0.9	8.8	0.8	7	0.6	4.8	0.6	4	115																													
t _{PHZ}	ŌĒ	А	4.7	1	8.4	1	8.4	1	6.2	1	6.6	ns																													
t _{PLZ}	UE	~	4.7	1	8.4	1	8.4	1	6.2	1	6.6	115																													
t _{PHZ}	ŌĒ	в	4.5	1.5	9.4	1.3	8.2	1.1	6.2	0.9	5.2	ns																													
t _{PLZ}	UE	B	В	В	B	В	В	В	В	B	В	В	В	В	В	В	В	В	B	В	В	В	В	В	В	В	В	В	В	В	В	4.5	1.5	9.4	1.3	8.2	1.1	6.2	0.9	5.2	115

over recommended operating free-air temperature range, $V_{CCA} = 2.5V \pm 0.2V$ (see Figure 6-1)

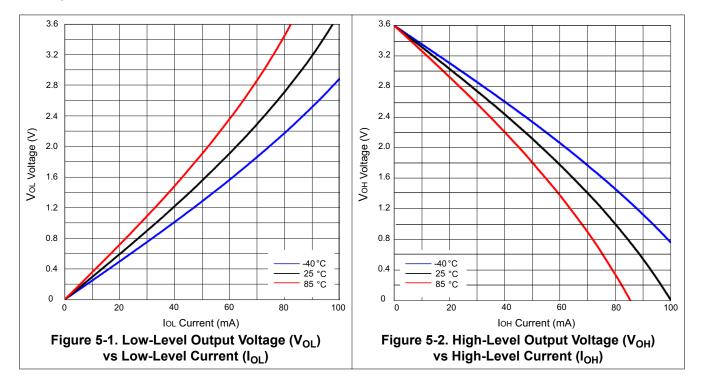
5.11 Switching Characteristics: V_{CCA} = $3.3V \pm 0.3V$

over recommended operating free-air temperature range, V_{CCA} = 3.3V ± 0.3V (see Figure 6-1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.2V	V _{CCB} = ± 0.7		V _{ССВ} = ± 0.1		V _{CCB} = ± 0.2		V _{ССВ} = ± 0.3		UNIT		
		(001101)	TYP	MIN	MAX	MIN	MAX	MIN MAX	MIN	MAX				
t _{PLH}	А	В	2.9	0.1	5.6	0.1	4.5	0.1	3.3	0.1	2.9	20		
t _{PHL}	A	D	2.9	0.1	5.6	0.1	4.5	0.1	3.3	0.1	2.9	ns		
t _{PLH}	В	А	2.6	0.6	4.2	0.4	3.4	0.2	3	0.1	2.8	ns		
t _{PHL}	D	A	2.6	0.6	4.2	0.4	3.4	0.2	3	0.1	2.8	115		
t _{PZH}	ŌĒ	Α	3.8	0.6	8.7	0.6	5.2	0.6	3.8	0.4	3.8	ns		
t _{PZL}	UL	~	3.8	0.6	8.7	0.6	5.2	0.6	3.8	0.4	3.8	115		
t _{PZH}	ŌĒ	В	3.7	0.8	8.7	0.6	6.8	0.5	4.7	0.5	3.8	20		
t _{PZL}	UE	D	3.7	0.8	8.7	0.6	6.8	0.5	4.7	0.5	3.8	ns		
t _{PHZ}	ŌĒ	А	4.8	0.7	9.3	0.7	8.3	0.7	5.6	0.7	6.6	20		
t _{PLZ}	UE	A .	4.8	0.7	9.3	0.7	8.3	0.7	5.6	0.7	6.6	ns		
t _{PHZ}	ŌĒ	P	5.3	1.4	9.3	1.2	8.1	1	6.4	0.8	6.2	20		
t _{PLZ}	UE	В	В —	В	5.3	1.4	9.3	1.2	8.1	1	6.4	0.8	6.2	ns



5.12 Typical Characteristics



Vcci

0 V

 V_{CCA}

0 V

V_{cco}

V_{OL}

VOH

0 V

$2 \times V_{CCO}$ TEST **S1** S Open RL t_{pd} Open From Output t_{PLZ}/t_{PZL} $2 \times V_{CCO}$ GND Under Test GND t_{PHZ}/t_{PZH} CL R_L (see Note A) LOAD CIRCUIT V_{CCI}/2 V_{CCI}/2 Input CL Vcco RL VTP 1.2 V 15 pF **2 k**Ω 0.1 V **VOLTAGE WAVEFORMS** 1.5 V ± 0.1 V 15 pF **2 k**Ω 0.1 V PULSE DURATION 1.8 V ± 0.15 V 15 pF **2 k**Ω 0.15 V $2.5~V\pm0.2~V$ **2 k**Ω 0.15 V 15 pF $3.3 \text{ V} \pm 0.3 \text{ V}$ **2 k**Ω 0.3 V 15 pF Output Control V_{CCA}/2 V_{CCA}/2 (low-level enabling) t_{PLZ} t_{P71} Output Vcci Waveform 1 V_{CCO}/2 Input V_{CCI}/2 V_{CCI}/2 V_{OL} + V_{TP} S1 at 2 × V_{CCO} 0 V (see Note B) t_{PHZ} t_{PZH} t_{PLH} t_{PHL} Output Waveform 2 VOH V_{OH} - V_{TP} V_{CCO}/2 S1 at GND V_{CCO}/2 Output V_{CCO}/2 (see Note B) V_{OL} **VOLTAGE WAVEFORMS VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES ENABLE AND DISABLE TIMES**

6 Parameter Measurement Information

NOTES: A. C₁ includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR 10 MHz, $Z_{O} = 50 \Omega$, dv/dt \geq 1 V/ns.

- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. V_{CCI} is the V_{CC} associated with the input port.
- I. V_{CCO} is the V_{CC} associated with the output port.

Figure 6-1. Load and Circuit and Voltage Waveforms



7 Detailed Description

7.1 Overview

The SN74AVC4T245 is a 4-bit, dual-supply noninverting bidirectional voltage level translation device. V_{CCA} supports the Ax pins and control pins (1DIR, 2DIR,1 \overline{OE} , and 2 \overline{OE}), and V_{CCB} supports the Bx pins. The A port can accept I/O voltages ranging from 1.2V to 3.6V, while the B port can accept I/O voltages from

1.2V to 3.6V. A high on DIR allows data transmission from Ax to Bx and a low on DIR allows data transmission from Bx to Ax when \overline{OE} is set to low. When \overline{OE} is set to high, both Ax and Bx pins are in the high-impedance state.

7.2 Functional Block Diagram

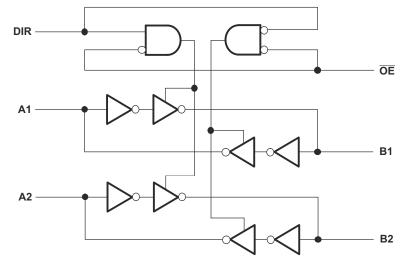


Figure 7-1. Logic Diagram (Positive Logic) for 1/2 of SN74AVC4T245



7.3 Feature Description

7.3.1 Fully Configurable Dual-Rail Design

The fully configurable dual-rail design allows each port to operate over the full 1.2V to 3.6V power-supply range. Both V_{CCA} and V_{CCB} can be supplied at any voltage between 1.2V and 3.6V; thus, making the device an excellent choice for translating between any of the low voltage nodes (1.2V, 1.8V, 2.5V, and 3.3V).

7.3.2 Supports High Speed Translation

The SN74AVC4T245 device can support high data rate applications. The translated signal data rate can be up to 380Mbps when the signal is translated from 1.8V to 3.3V.

7.3.3 Ioff Supports Partial-Power-Down Mode Operation

I_{off} will prevent backflow current by disabling I/O output circuits when the device is in partial-power-down mode.

7.4 Device Functional Modes

		Each 2-Bit	Section)	
CONTRO	L INPUTS	OUTPUT O	RCUITS	OPERATION ⁽¹⁾
ŌĒ	DIR	A PORT	B PORT	OPERATION
L	L	Enabled	Hi-Z	B data to A bus
L	Н	Hi-Z	Enabled	A data to B bus
н	Х	Hi-Z	Hi-Z	Isolation

Table 7-1. Function Table

(1) Input circuits of the data I/Os are always active.



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The SN74AVC4T245 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The SN74AVC4T245 device is an excellent choice for applications where a push-pull driver is connected to the data I/Os. The maximum data rate can be up to 380Mbps when device translates a signal from 1.8V to 3.3V.

8.2 Typical Application

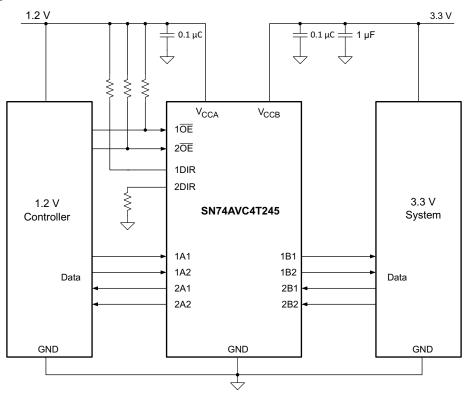


Figure 8-1. Typical Application Diagram



8.2.1 Design Requirements

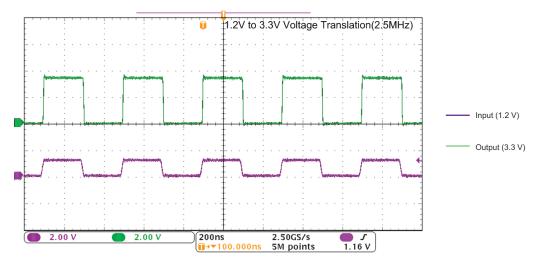
For the design example shown in Section 8.2 use the parameters listed in Table 8-1.

Table 8-1. Des	sign Parameters
DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	1.2V to 3.6V
Output voltage range	1.2V to 3.6V

8.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
 - Use the supply voltage of the device that is driving the SN74AVC4T245 device to determine the input voltage range. For a valid logic high, the value must exceed the V_{IH} of the input port. For a valid logic low, the value must be less than the V_{IL} of the input port.
- Output voltage range
 - Use the supply voltage of the device that the SN74AVC4T245 device is driving to determine the output voltage range.



8.2.3 Application Curves

Figure 8-2. Translation Up (1.2V to 3.3V) at 2.5MHz

8.3 Power Supply Recommendations

The SN74AVC4T245 device uses two separate configurable power-supply rails, V_{CCA} and V_{CCB}. V_{CCA} accepts any supply voltage from 1.2V to 3.6V and V_{CCB} accepts any supply voltage from 1.2V to 3.6V. The A port and B port are designed to track V_{CCA} and V_{CCB} respectively allowing for low-voltage bidirectional translation between any of the 1.2V, 1.5V, 1.8V, 2.5V and 3.3V voltage nodes.

The output-enable (\overline{OE}) input circuit is designed so that V_{CCA} supplies \overline{OE} , and when the \overline{OE} input is high, all outputs are placed in the high-impedance state. To put the outputs in the high-impedance state during power up or power down, the OE input pin must be tied to V_{CCA} through a pullup resistor and must not be enabled until V_{CCA} and V_{CCB} are fully ramped and stable. The current-sinking capability of the driver determines the minimum value of the pullup resistor to V_{CCA}.



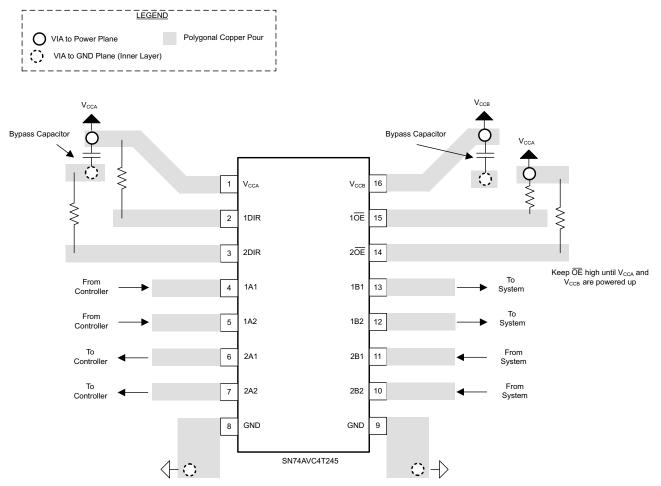
8.4 Layout

8.4.1 Layout Guidelines

For device reliability, it is recommended to follow common printed-circuit board layout guidelines, such as follows:

- Bypass capacitors should be used on power supplies.
- Short trace lengths should be used to avoid excessive loading.
- Place pads on the signal paths for loading capacitors or pullup resistors to help adjust rise and fall times of signals, depending on the system requirements.

8.4.2 Layout Example





9 Device and Documentation Support

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.3 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	Changes from Revision H (March 2024) to Revision I (February 2025)	Page
•	Updated PW and RGY thermal information	8

С	hanges from Revision G (November 2014) to Revision H (March 2024)	Page
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Added the BQB and DYY package information throughout the data sheet	1
•	Updated the package information table to include package lead size	1

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
74AVC4T245DGVRE4	Active	Production	TVSOP (DGV) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
74AVC4T245RGYRG4	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT245
74AVC4T245RSVR-NT	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZWU
74AVC4T245RSVR-NT.A	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ZWU
74AVC4T245RSVR-NT.B	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ZWU
74AVC4T245RSVRG4	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZWU
SN74AVC4T245BQBR	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245BQBR.A	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245D	Active	Production	SOIC (D) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AVC4T245
SN74AVC4T245D.B	Active	Production	SOIC (D) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AVC4T245
SN74AVC4T245DG4.B	Active	Production	SOIC (D) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AVC4T245
SN74AVC4T245DGVR	Active	Production	TVSOP (DGV) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245DGVR.B	Active	Production	TVSOP (DGV) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245DR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AVC4T245
SN74AVC4T245DR.B	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AVC4T245
SN74AVC4T245DRE4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AVC4T245
SN74AVC4T245DT	Active	Production	SOIC (D) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AVC4T245
SN74AVC4T245DT.B	Active	Production	SOIC (D) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AVC4T245
SN74AVC4T245DYYR	Active	Production	SOT-23-THIN (DYY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245DYYR.A	Active	Production	SOT-23-THIN (DYY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245PW	Active	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PW.B	Active	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245PWE4	Active	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245PWR.B	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245PWRE4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PWRG4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245



23-May-2025

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(3)	(4)	(5)		(6)
SN74AVC4T245PWT	Active	Production	TSSOP (PW) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PWT.B	Active	Production	TSSOP (PW) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	WT245
SN74AVC4T245PWTE4	Active	Production	TSSOP (PW) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245PWTG4	Active	Production	TSSOP (PW) 16	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT245
SN74AVC4T245RGYR	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT245
SN74AVC4T245RGYR.A	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	WT245
SN74AVC4T245RGYR.B	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	WT245
SN74AVC4T245RGYRG4.A	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	WT245
SN74AVC4T245RGYRG4.B	Active	Production	VQFN (RGY) 16	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	WT245
SN74AVC4T245RSVR	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZWU
SN74AVC4T245RSVR.A	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ZWU
SN74AVC4T245RSVR.B	Active	Production	UQFN (RSV) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ZWU

⁽¹⁾ **Status:** For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.



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PACKAGE OPTION ADDENDUM

23-May-2025

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OTHER QUALIFIED VERSIONS OF SN74AVC4T245 :

• Automotive : SN74AVC4T245-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

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TEXAS

NSTRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74AVC4T245RSVR-NT	UQFN	RSV	16	3000	180.0	9.5	2.1	2.9	0.75	4.0	8.0	Q1
74AVC4T245RSVR-NT	UQFN	RSV	16	3000	180.0	8.4	2.0	2.8	0.7	4.0	8.0	Q1
SN74AVC4T245BQBR	WQFN	BQB	16	3000	180.0	12.4	2.8	3.8	1.2	4.0	12.0	Q1
SN74AVC4T245DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74AVC4T245DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74AVC4T245DYYR	SOT-23- THIN	DYY	16	3000	330.0	12.4	4.8	3.6	1.6	8.0	12.0	Q3
SN74AVC4T245PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AVC4T245PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AVC4T245RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
SN74AVC4T245RSVR	UQFN	RSV	16	3000	178.0	13.5	2.1	2.9	0.75	4.0	12.0	Q1



www.ti.com

PACKAGE MATERIALS INFORMATION

23-May-2025



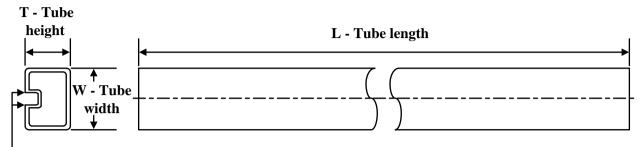
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74AVC4T245RSVR-NT	UQFN	RSV	16	3000	189.0	185.0	36.0
74AVC4T245RSVR-NT	UQFN	RSV	16	3000	200.0	183.0	25.0
SN74AVC4T245BQBR	WQFN	BQB	16	3000	210.0	185.0	35.0
SN74AVC4T245DGVR	TVSOP	DGV	16	2000	356.0	356.0	35.0
SN74AVC4T245DR	SOIC	D	16	2500	353.0	353.0	32.0
SN74AVC4T245DYYR	SOT-23-THIN	DYY	16	3000	336.6	336.6	31.8
SN74AVC4T245PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74AVC4T245PWT	TSSOP	PW	16	250	356.0	356.0	35.0
SN74AVC4T245RGYR	VQFN	RGY	16	3000	356.0	356.0	35.0
SN74AVC4T245RSVR	UQFN	RSV	16	3000	189.0	185.0	36.0

TEXAS INSTRUMENTS

www.ti.com

23-May-2025

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN74AVC4T245D	D	SOIC	16	40	507	8	3940	4.32
SN74AVC4T245D.B	D	SOIC	16	40	507	8	3940	4.32
SN74AVC4T245DG4.B	D	SOIC	16	40	507	8	3940	4.32
SN74AVC4T245PW	PW	TSSOP	16	90	530	10.2	3600	3.5
SN74AVC4T245PW.B	PW	TSSOP	16	90	530	10.2	3600	3.5
SN74AVC4T245PWE4	PW	TSSOP	16	90	530	10.2	3600	3.5

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

RSV 16

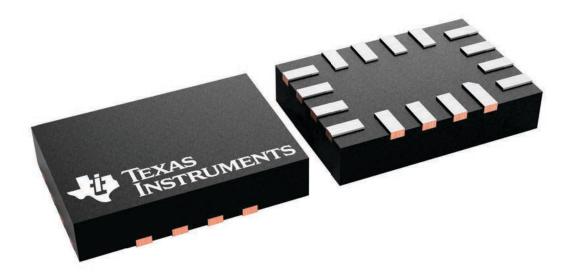
1.8 x 2.6, 0.4 mm pitch

GENERIC PACKAGE VIEW

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





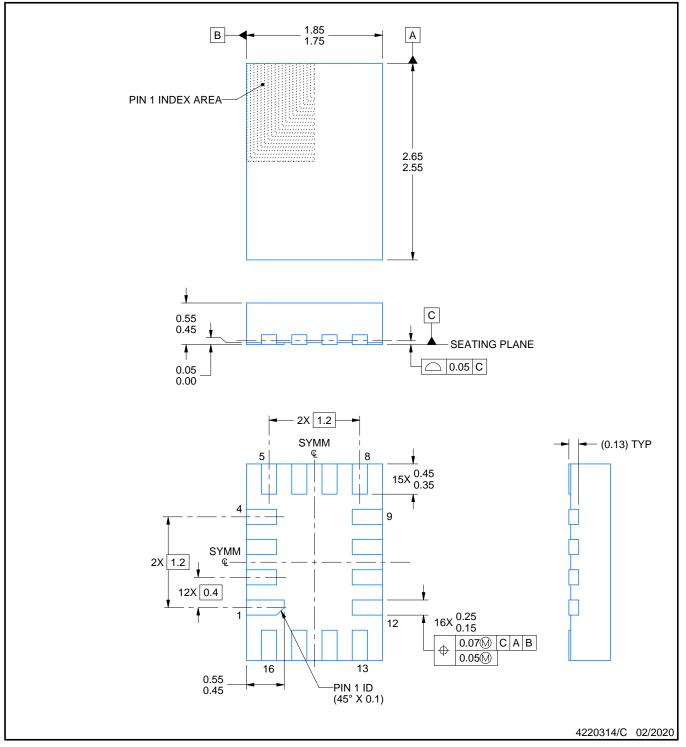
RSV0016A



PACKAGE OUTLINE

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



NOTES:

All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.

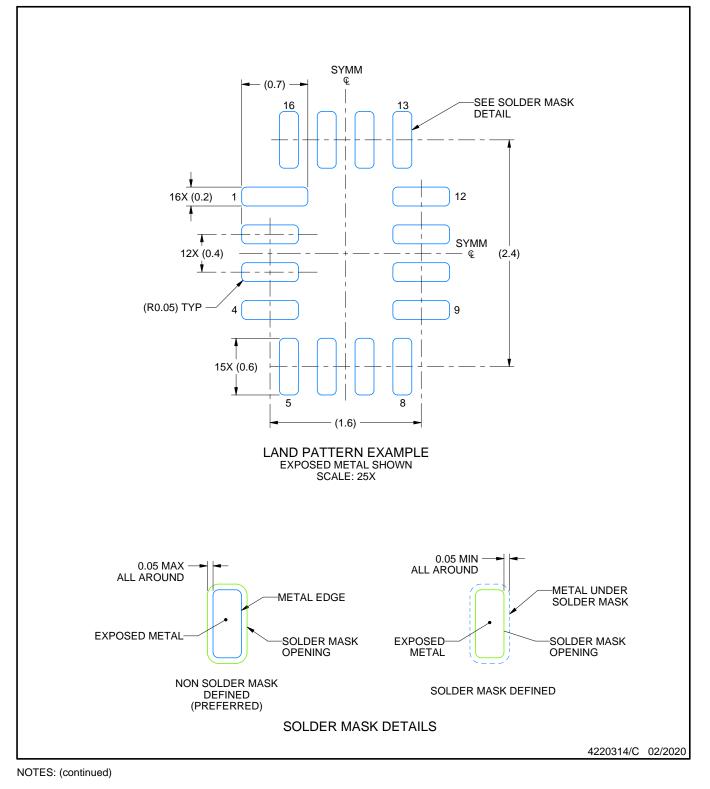


RSV0016A

EXAMPLE BOARD LAYOUT

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

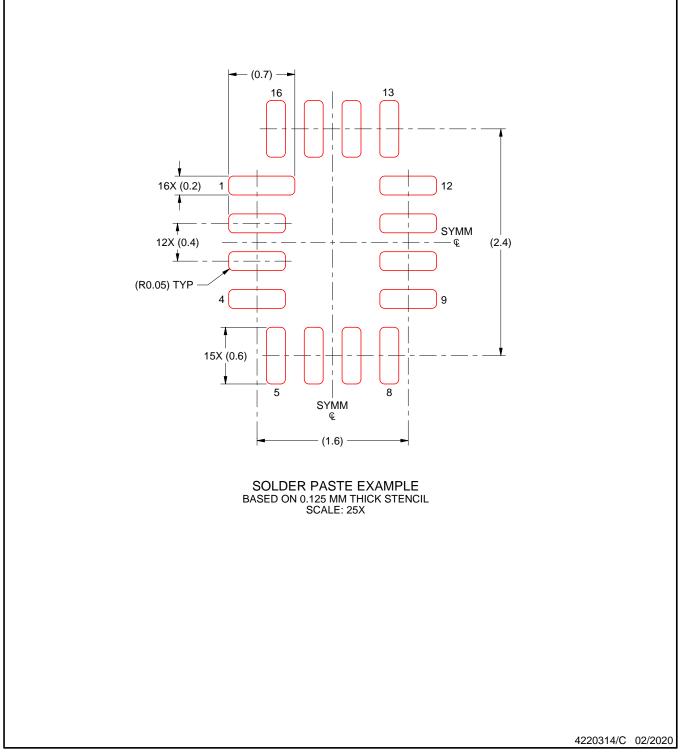


RSV0016A

EXAMPLE STENCIL DESIGN

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



BQB 16

GENERIC PACKAGE VIEW

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

2.5 x 3.5, 0.5 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





BQB0016A

PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



BQB0016A

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

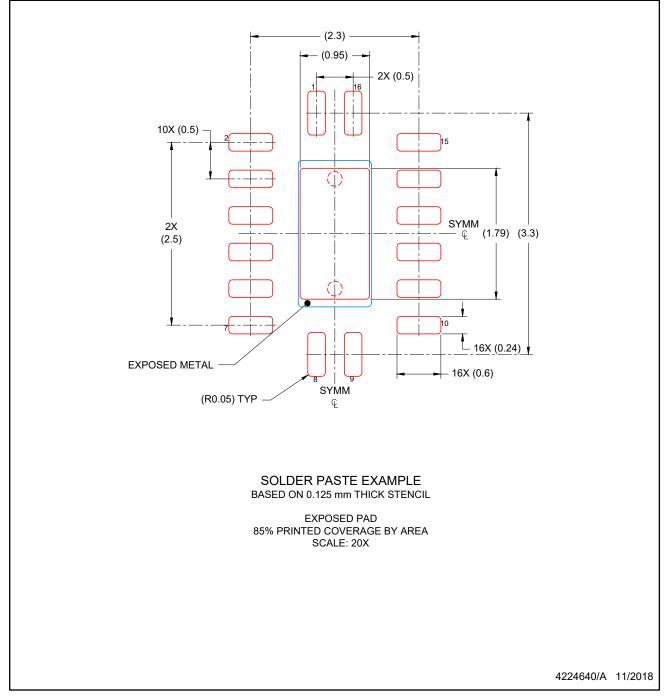


BQB0016A

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

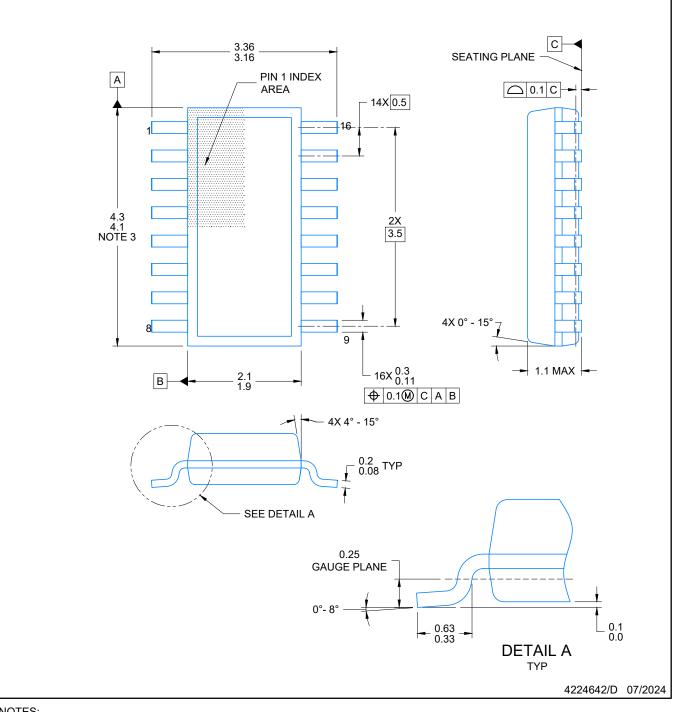


DYY0016A

PACKAGE OUTLINE

SOT-23-THIN - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 3. 0.15 per side.
- This dimension does not include interlead flash. Interlead flash shall not exceed 0.50 per side. 4.
- Reference JEDEC Registration MO-345, Variation AA 5.

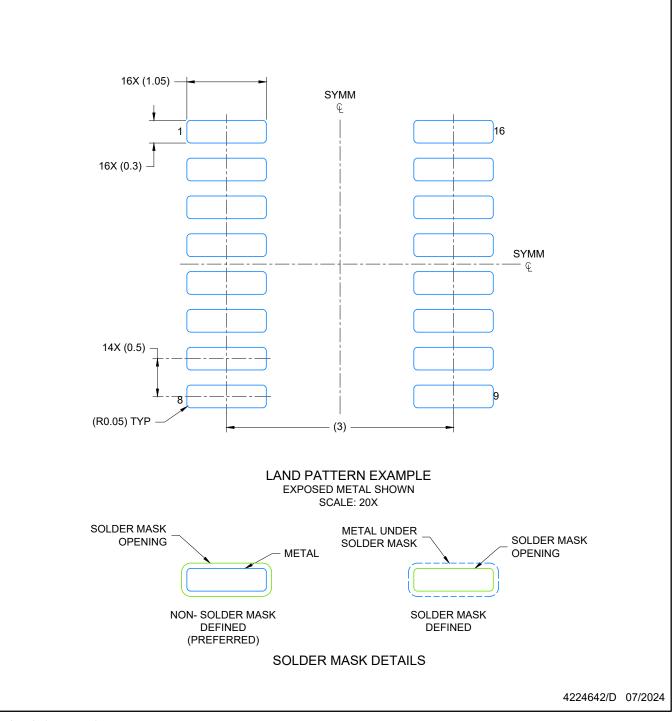


DYY0016A

EXAMPLE BOARD LAYOUT

SOT-23-THIN - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

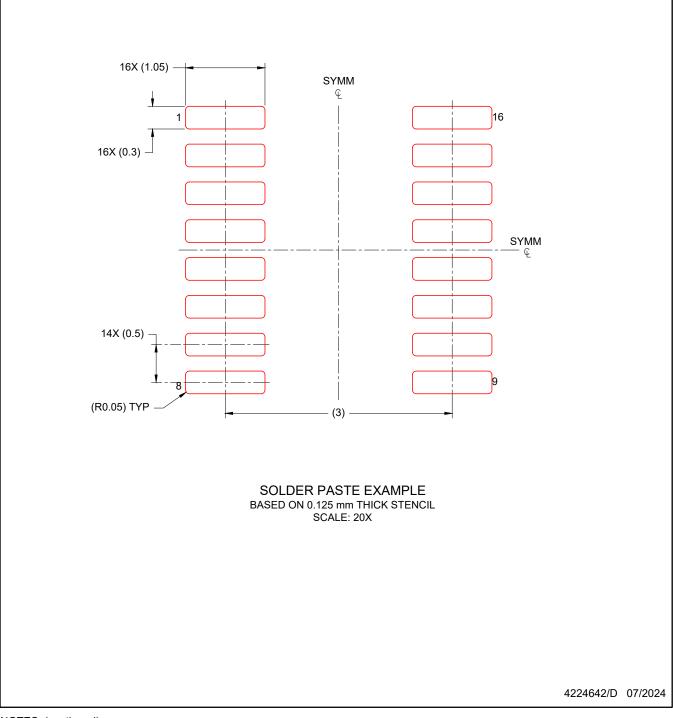


DYY0016A

EXAMPLE STENCIL DESIGN

SOT-23-THIN - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA



- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- Ε. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Æ Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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